Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/830,222	MIURA ET AL.		
Examiner	Art Unit		
Xu Mei	2615		

SEARCHED				
Subclass	Date	Examiner		
56	11/01/06	Xr_		
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	Subclass 56 57	Subclass Date 56 11/01/06 57 58 77 94 602 608		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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